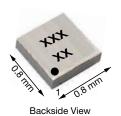


Vishay Siliconix

# N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) MAX.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (TYP.)				
20	0.075 at V <sub>GS</sub> = 4.5 V	2.9					
	0.082 at V <sub>GS</sub> = 2.5 V	2.7					
	0.090 at V <sub>GS</sub> = 1.8 V	2.6	2.7 nC				
	0.125 at V <sub>GS</sub> = 1.5 V	2.2					
	0.175 at V <sub>GS</sub> = 1.2 V	1.5					

#### .





Marking Code: AM Ordering Information:

Si8824EDB-T2-E1 (Lead (Pb)-free and Halogen-free)

#### **FEATURES**

- TrenchFET® power MOSFET
- Ultra small 0.8 mm x 0.8 mm outline
- Ultra thin 0.357 mm height
- Typical ESD protection 2000 V (HBM)
- Material categorization: for definitions of compliance please see <a href="https://www.vishav.com/doc?99912">www.vishav.com/doc?99912</a>

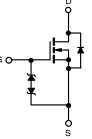
# Pb-free

RoHS COMPLIANT

HALOGEN FREE

#### **APPLICATIONS**

- Ultraportable and wearable devices
- · Load switch with low voltage drop
- Load switch for 1.2 V, 1.5 V, and 1.8 V power lines
- · Small signal and high speed switching



N-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	/ <sub>DS</sub> 20		
Gate-Source Voltage		V <sub>GS</sub>	± 5	V	
	T <sub>A</sub> = 25 °C		2.9 <sup>a</sup>		
Continues Durin Comment /T. 150 °C)	T <sub>A</sub> = 70 °C		2.3 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	2.1 <sup>b</sup>		
	T <sub>A</sub> = 70 °C		1.7 <sup>b</sup>	A	
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub>	15		
Ossilia as a Ossia Baila Bisala Ossiala	T <sub>A</sub> = 25 °C		0.7 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.4 b		
	T <sub>A</sub> = 25 °C		0.9 <sup>a</sup>		
Martin or Branch Black attack	T <sub>A</sub> = 70 °C		0.6 <sup>a</sup>	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.5 b		
	T <sub>A</sub> = 70 °C		0.3 b		
Operating Junction and Storage Temperatur	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150			
Soldering Recommendations (Peak Temperature		260	°C		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum Junction-to-Ambient a, d	t ≤ 5 s	В	105	135	°C/W		
Maximum Junction-to-Ambient b, e	ı≤ss	R <sub>thJA</sub>	200	260	] C/W		

#### Notes

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
- c. Refer to IPC / JEDEC® (J-STD-020), no manual or hand soldering.
- d. Maximum under steady state conditions is 185 °C / W.
- e. Maximum under steady state conditions is 330  $^{\circ}\text{C}$  / W.



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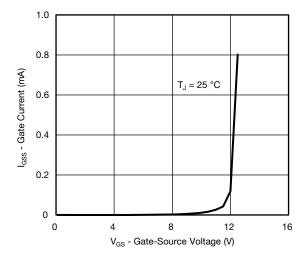
PARAMETER	SYMBOL TEST CONDITIONS			TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS} / T_{J}$	L = 250 mA		13	-	mV / °C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}$ / $T_J$	I <sub>D</sub> = 250 μA	-	-2	-	miv/ C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	0.35	-	0.8	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$	-		± 2	
Zana Oala Wallana Buria Oanaal	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	-	-	1	μA
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	10	-	-	Α
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1 A	-	0.060	0.075	
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1 A	-	0.065	0.082	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 1.8 \text{ V}, I_D = 0.5 \text{ A}$	ı	0.070	0.090	Ω
		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 0.5 A	1	0.080	0.125	
		V <sub>GS</sub> = 1.2 V, I <sub>D</sub> = 0.1 A	1	0.090	0.175	
Forward Transconductance <sup>a</sup> $g_{fs}$ $V_{DS} = 10 \text{ V}, I_D = 1 \text{ A}$		V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 A	-	11	-	S
Dynamic <sup>b</sup>				•		
Input Capacitance	C <sub>iss</sub>		-	400	-	pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	60	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	35	-	
Total Gate Charge	$Q_{g}$		-	2.7	6	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$	ı	0.46	-	
Gate-Drain Charge	Q <sub>gd</sub>		1	0.93	-	
Gate Resistance	$R_{g}$	f = 1 MHz	1	3	-	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		-	5	10	
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_{L} = 10 \Omega$	1	20	40	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	1	17	35	
Fall Time	t <sub>f</sub>	1	-	10	20	
<b>Drain-Source Body Diode Characteristic</b>	cs					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	_	0.7	
Pulse Diode Forward Current	I <sub>SM</sub>	-	-	-	15	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 V	-	0.7	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	11	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1	-	5	10	nC
Reverse Recovery Fall Time	ta	$I_F = 1 \text{ A, dI / dt} = 100 \text{ A / } \mu\text{s, } T_J = 25 \text{ °C}$	-	7	-	1
Reverse Recovery Rise Time	t <sub>b</sub>	┥		4	-	ns

#### **Notes**

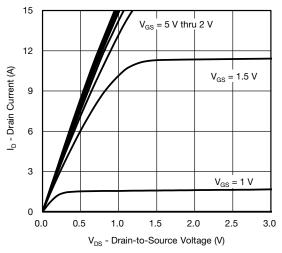
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

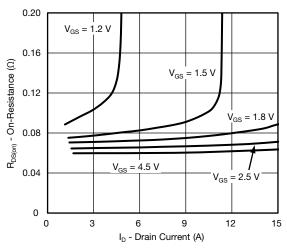




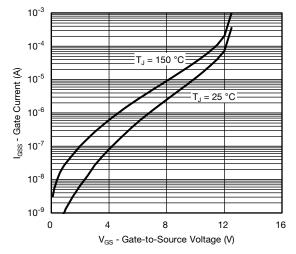
#### Gate Current vs. Gate-Source Voltage



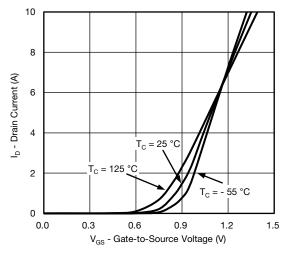
#### **Output Characteristics**



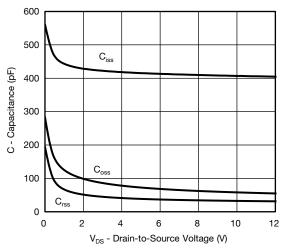
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage

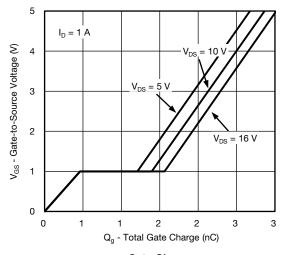


**Transfer Characteristics** 

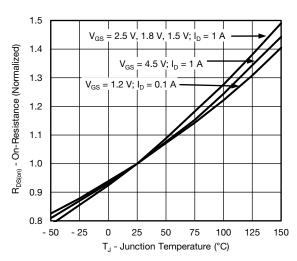


Capacitance vs. Drain-to-Source Voltage

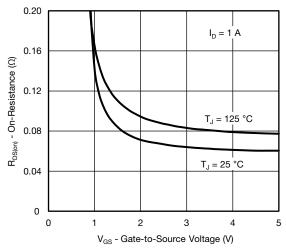




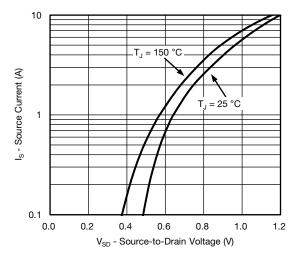
#### **Gate Charge**



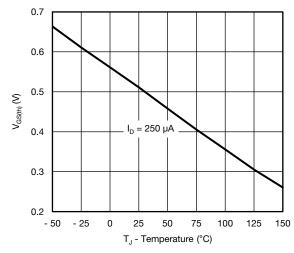
On-Resistance vs. Junction Temperature



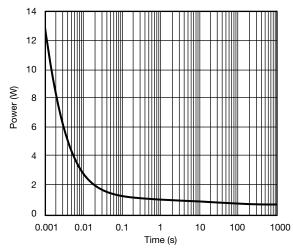
On-Resistance vs. Gate-to-Source Voltage



Source-Drain Diode Forward Voltage

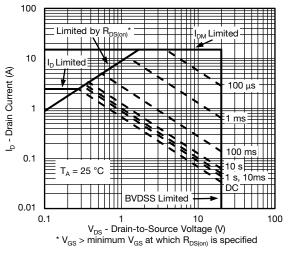


**Threshold Voltage** 

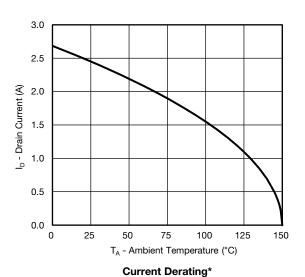


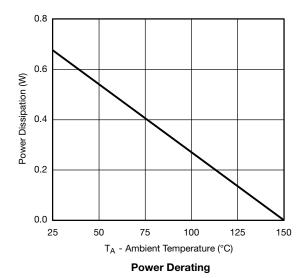
Single Pulse Power (Junction-to-Ambient)





Safe Operating Area, Junction-to-Ambient





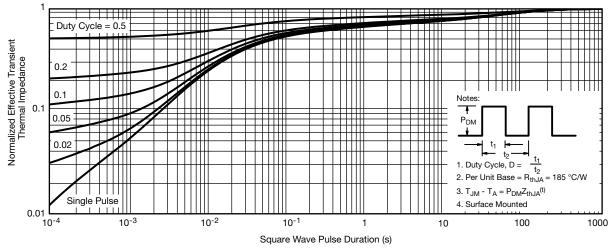
#### to.

#### Note

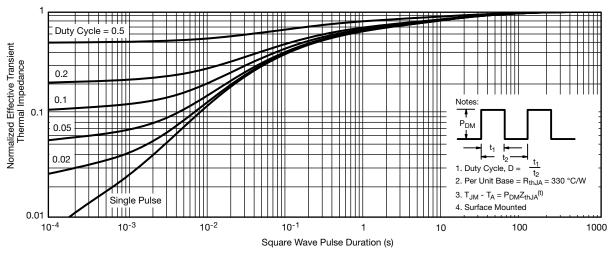
• When mounted on 1" x 1" FR4 with full copper.

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150 \,^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with maximum copper)



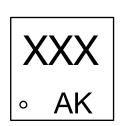
Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with minimum copper)

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg262978">www.vishay.com/ppg262978</a>.

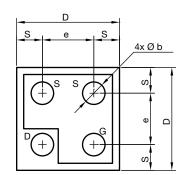
www.vishay.com

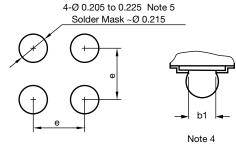
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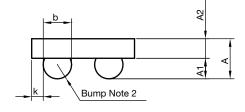
# MICRO FOOT®: 4-Bump (0.8 mm x 0.8 mm, 0.4 mm Pitch)



Mark on Backside of die







#### Notes

- (1) Laser mark on the backside surface of die
- (2) Bumps are 95.5 % Sn,3.8 % Ag,0.7 % Cu
- (3) "i" is the location of pin 1
- (4) "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- (5) Non-solder mask defined copper landing pad.

DIM.	MILLIMETERS a			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	0.328	0.365	0.402	0.0129	0.0144	0.0158
A1	0.136	0.160	0.184	0.0053	0.0062	0.0072
A2	0.192	0.205	0.218	0.0076	0.0081	0.0086
b	0.200	0.220	0.240	0.0078	0.0086	0.0094
b1	0.175			0.0068		
е	0.400			0.0157		
S	0.160	0.180	0.200	0.0062	0.0070	0.0078
D	0.720	0.760	0.800	0.0283	0.0299	0.0314
K	0.040	0.070	0.100	0.0015	0.0027	0.0039

#### Note

a. Use millimeters as the primary measurement.

ECN: T15-0053-Rev. A, 16-Feb-15 DWG: 6033

Revision: 16-Feb-15 1 Document Number: 69442



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Vishay

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